



# Characterization of the chemical signal created by CO oxidation on Pt/GaN nanodiodes

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J. Randy Creighton, Roger Pawlowski, Mike Coltrin, Jeff Figiel,  
and Kevin Baucom

Sandia National Laboratories  
Albuquerque, New Mexico 87185

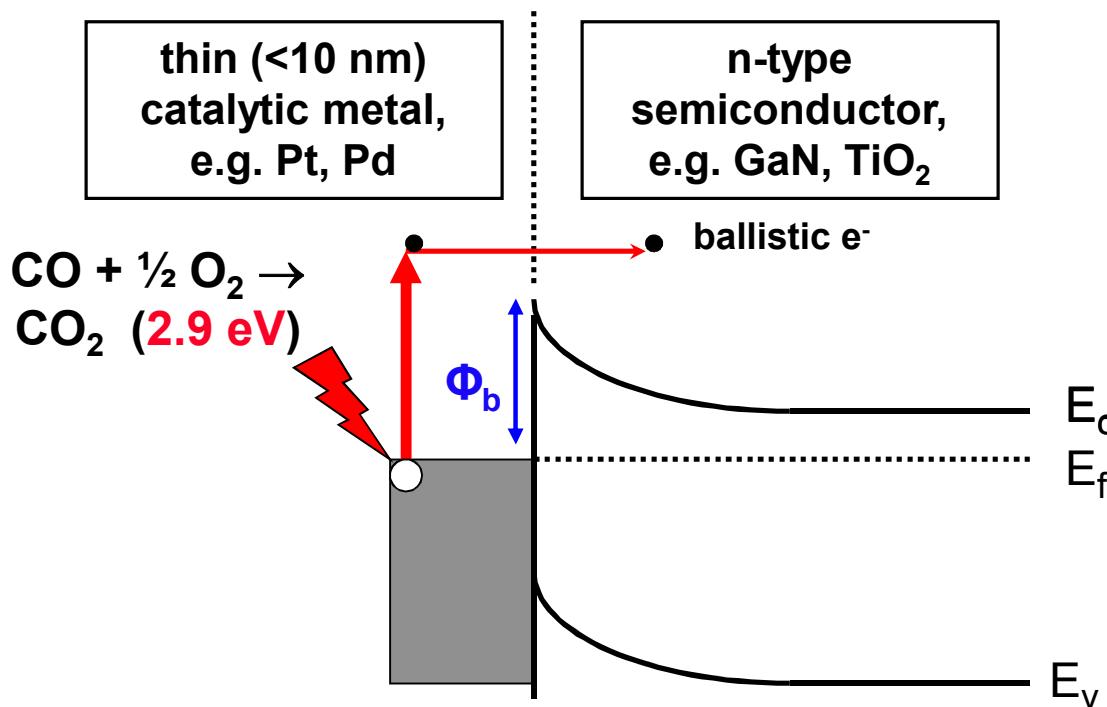
AVS 2010, Albuquerque, NM

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GaN deposition – Dan Koleske

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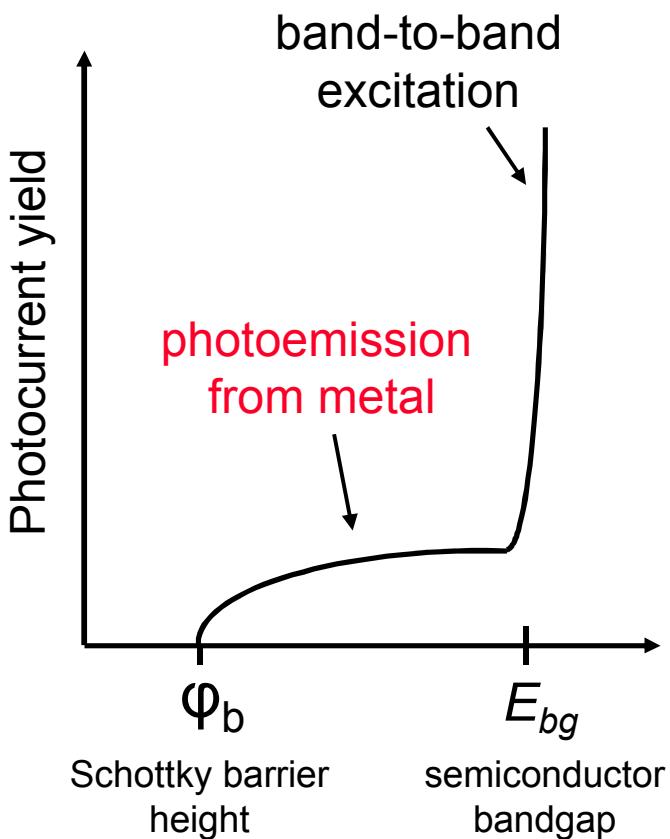
# What is a “Catalytic Nanodiode”?

- The catalytic nanodiode is a simple Schottky diode that converts chemical energy directly into electrical energy, via electronic excitation, i.e. hot electrons
- Somorjai et al. reported (2005) a reaction quantum yield (electrons/CO<sub>2</sub>) up to ~75% for the CO oxidation reaction on Pt/TiO<sub>2</sub>, coined the term “catalytic nanodiode”



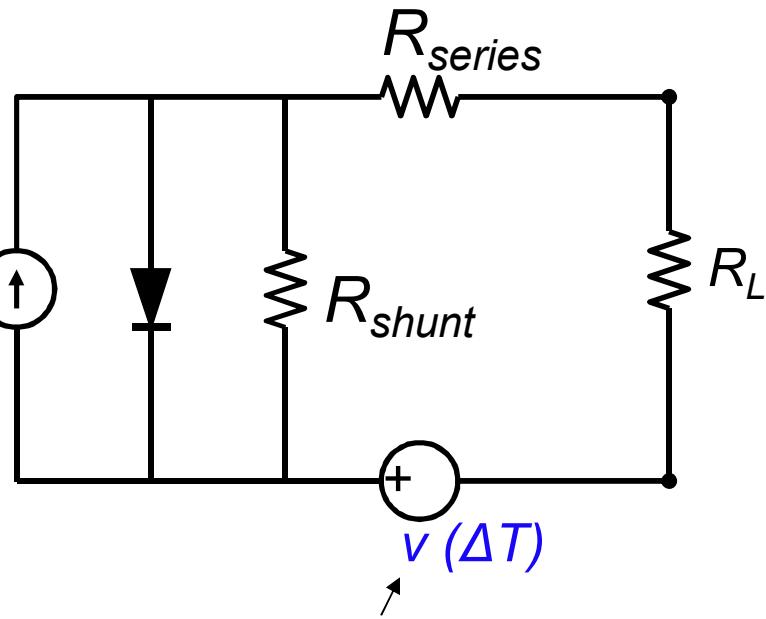


# Best analogy to catalytic nanodiode is a Schottky diode solar cell or photodiode with sub-bandgap illumination



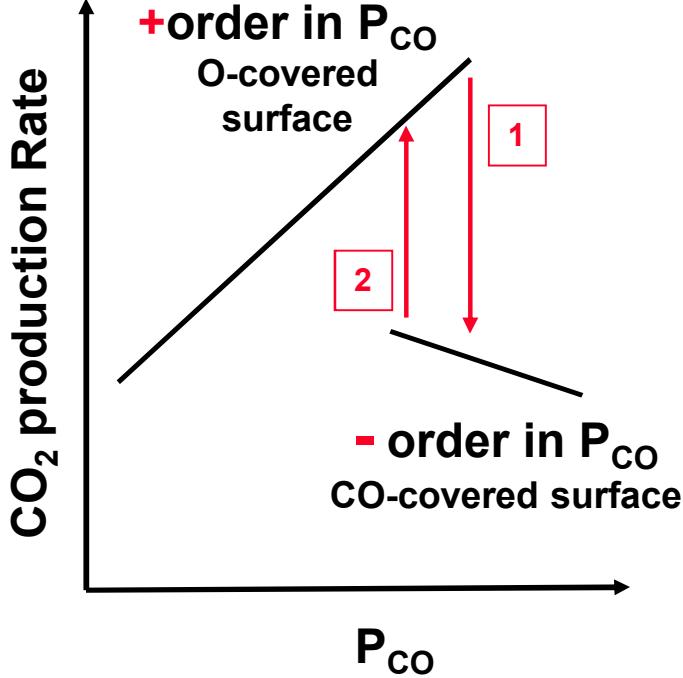
replace photocurrent with chemicurrent  $i$

equivalent circuit

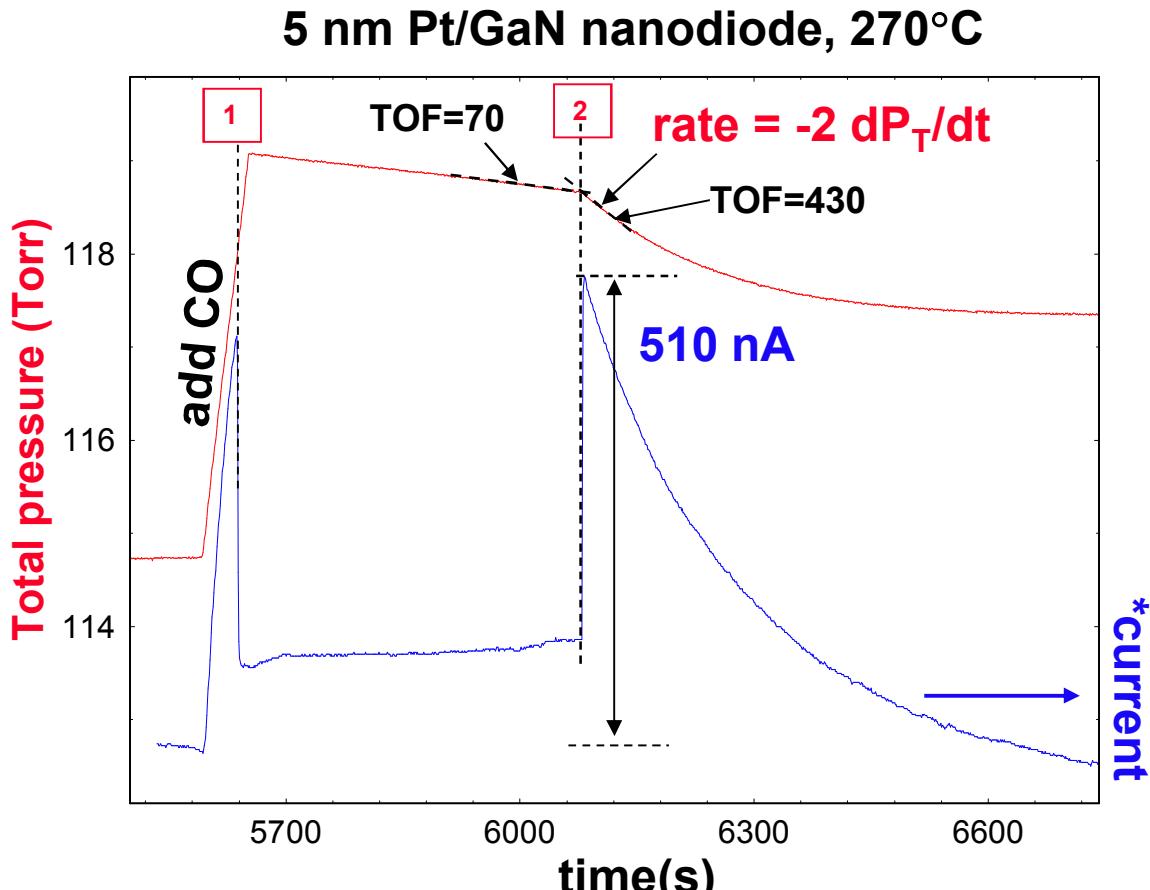


thermoelectric voltage,  
typically 0.3-1.0 mV  
before reaction conditions

# Kinetic phase transition during CO oxidation on Pt is observable using the nanodiode current



ref: e.g. Creighton JPC 1981

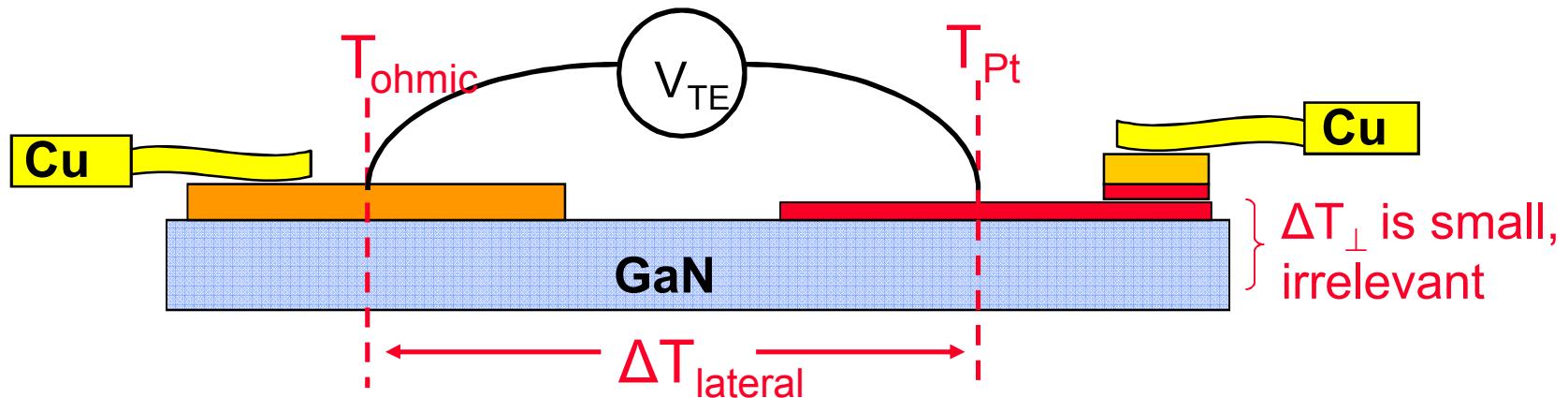


we use this lineshape as a fingerprint

\* using solar cell convention for chemicurrent



# Is the electronic signal due to “chemicurrent” or is it derived from a voltage source?



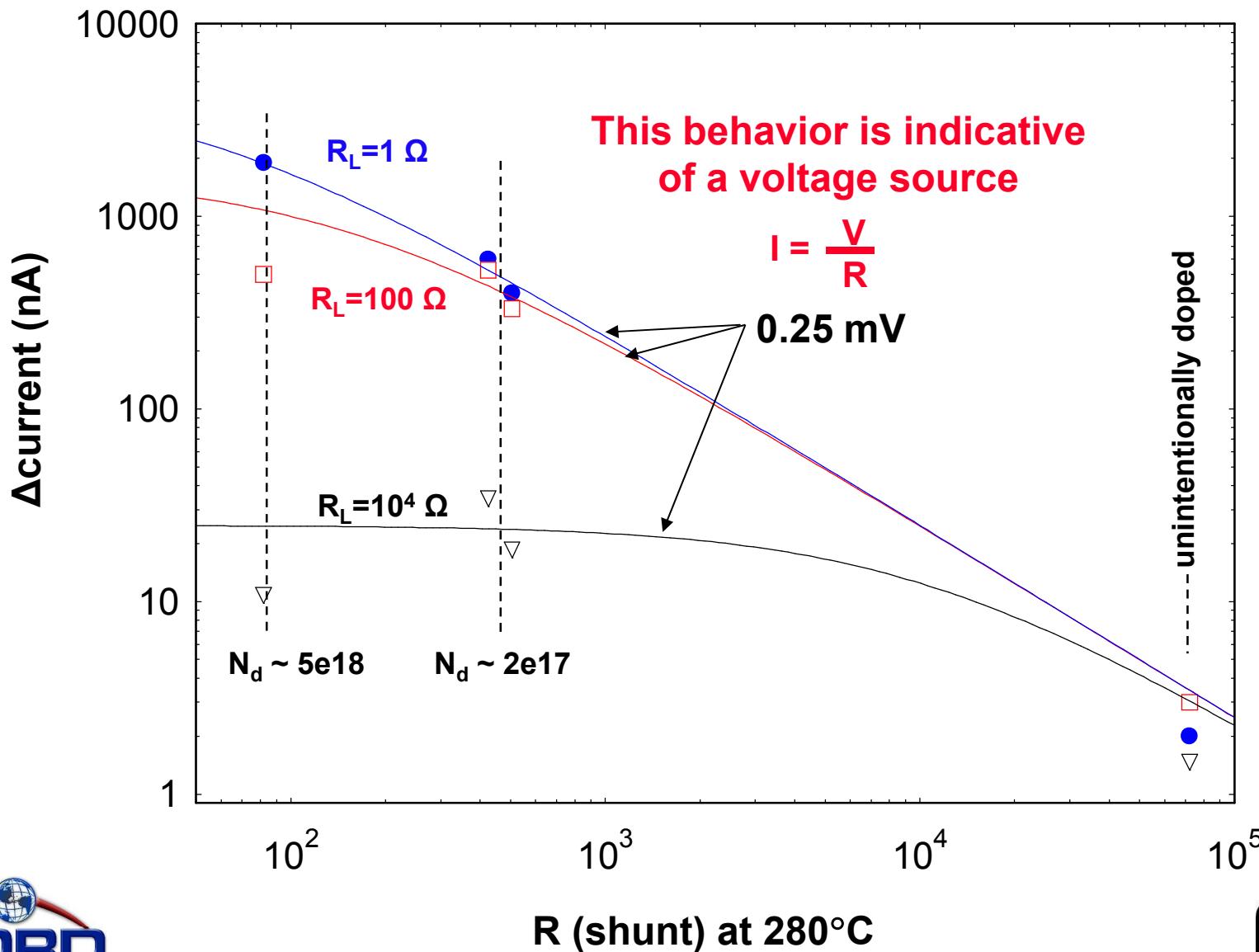
$$V_{TE} \sim (S_{GaN} - S_{Cu})\Delta T_{lat} + \text{much smaller terms}$$

$V_{TE}$  is mostly determined by:

- 1) GaN Seebeck coefficient;  $S_{GaN}$  [ typically  $\sim -400 \mu\text{V/deg}$ ]
- 2) the lateral temperature difference,  $\Delta T_{lat}$

only need  $\Delta T_{lat} \sim 1^\circ\text{C}$

# Vary $R_{\text{shunt}}$ by varying GaN doping level





# The 2 Burning Questions

**What is the magnitude of the Pt temperature rise,  
 $\Delta T_{Pt}$ , during reaction?**

**How much is the lateral temperature gradient,  
 $\Delta T_{lat}$ , affected by the reaction?**

Reaction is exothermic; 68 kcal/mole,  $\sim 2.9\text{eV}/\text{CO}_2$

For reaction TOF = 400, power density is **300 mW/cm<sup>2</sup>**

For reference: heater is dissipating 700 mW/cm<sup>2</sup> at 270°C

The heat liberated only needs to increase  **$\Delta T_{lat}$**  by  $\sim 1^\circ\text{C}$  in order to generate the measured signals



## We use both theoretical and experimental methods to address these 2 questions

Theoretical:

- “Simple” 1D and quasi-2D calculations

- Full 3D simulations of entire reactor

Experimental:

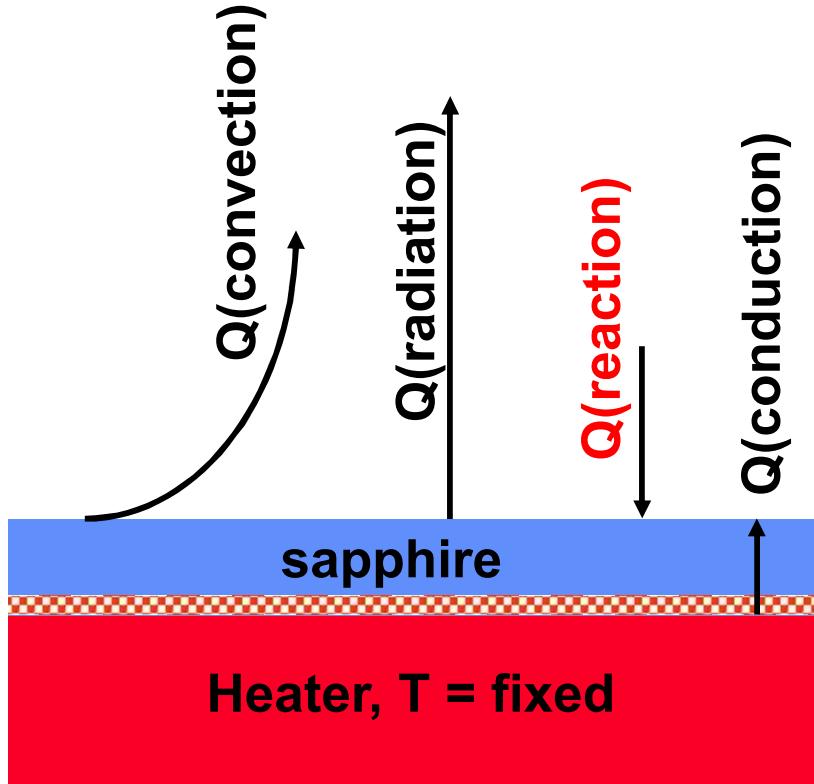
- mid-IR optical pyrometry of Pt surface:  $\Delta T_{Pt}$

- Thermocouple measurements of electrical contacts:  $\Delta T_{lat}$

# 1D calculation with isothermal heater

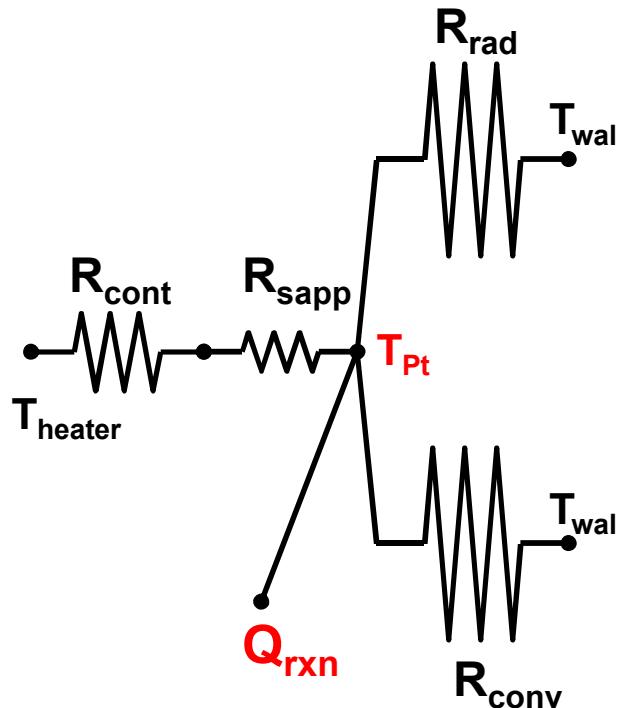
## Physical model

chamber wall,  $T = \text{fixed}$

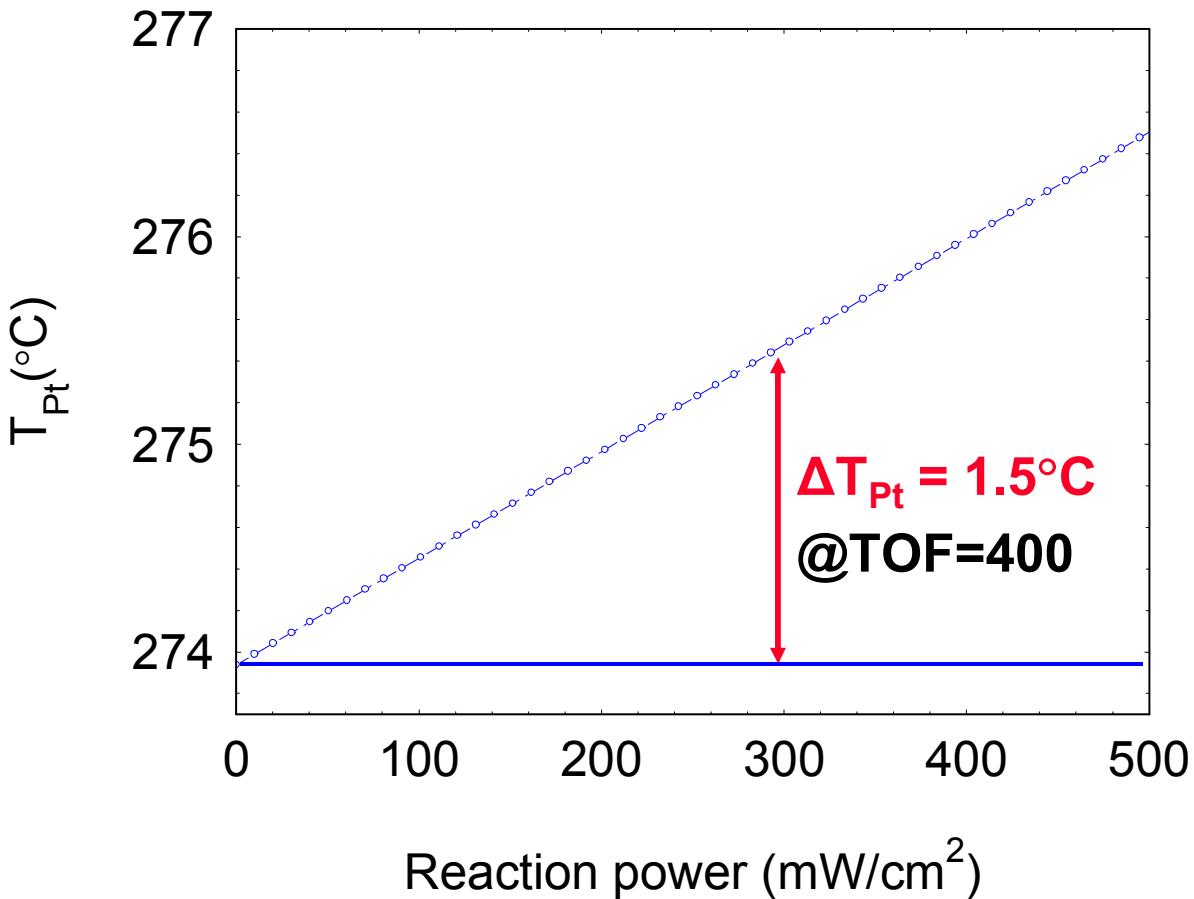


## Equivalent thermal circuit

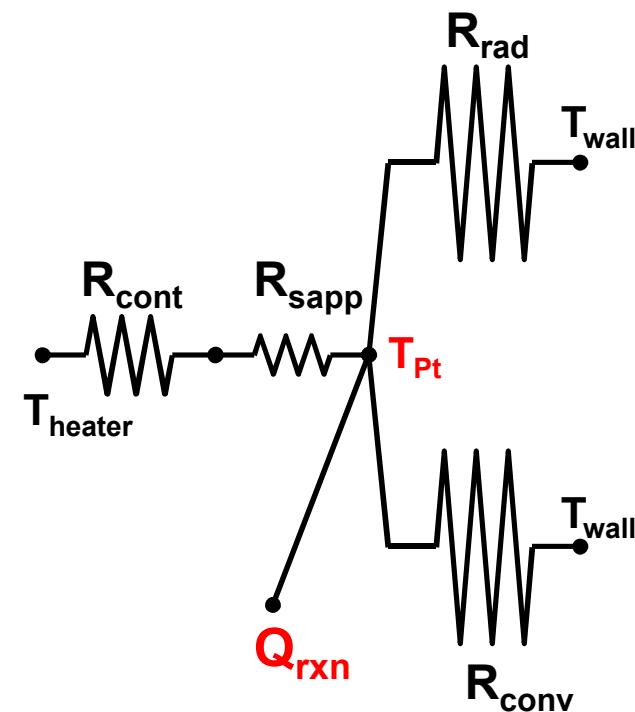
$$\Delta T = Q \cdot R_{\text{thermal}}$$



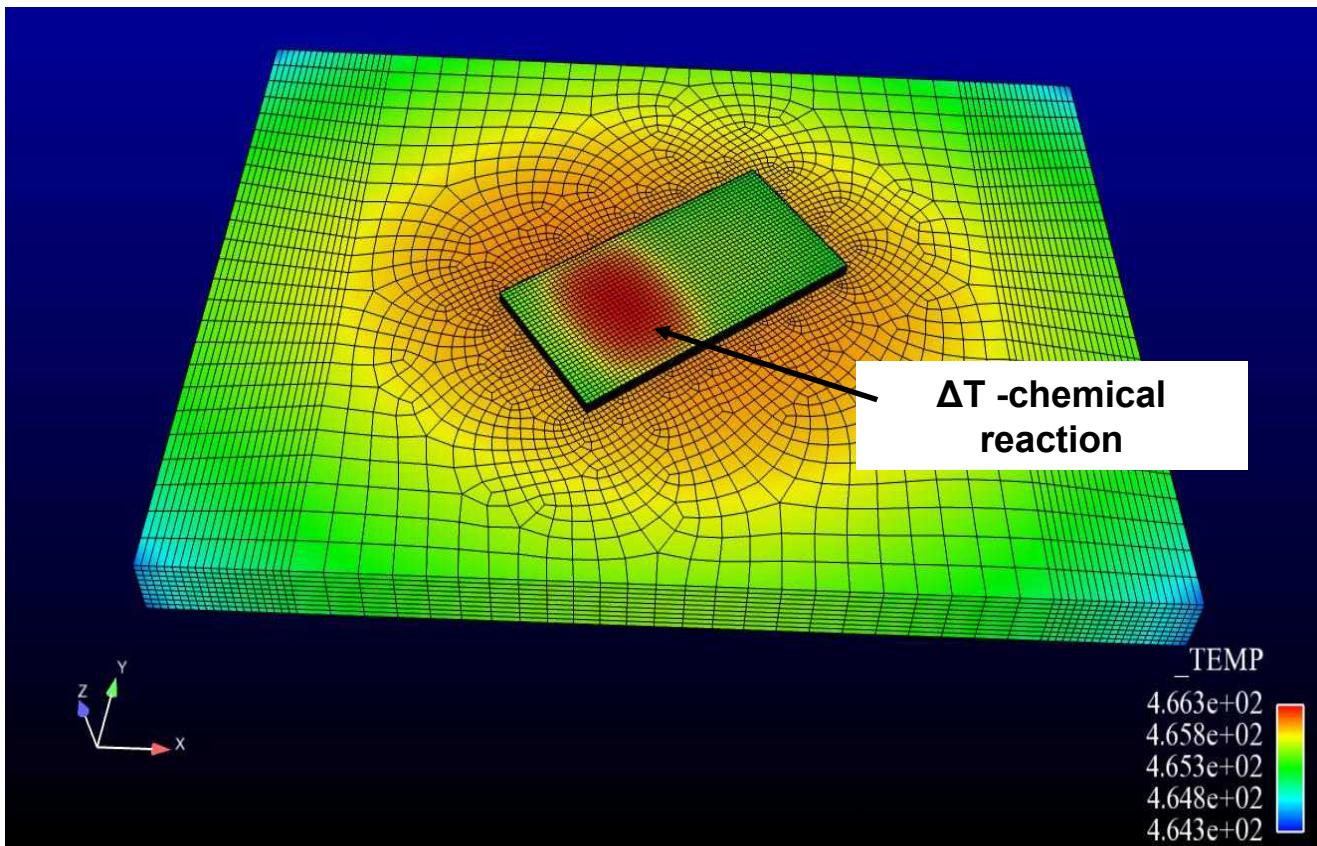
# 1D calculation with isothermal heater



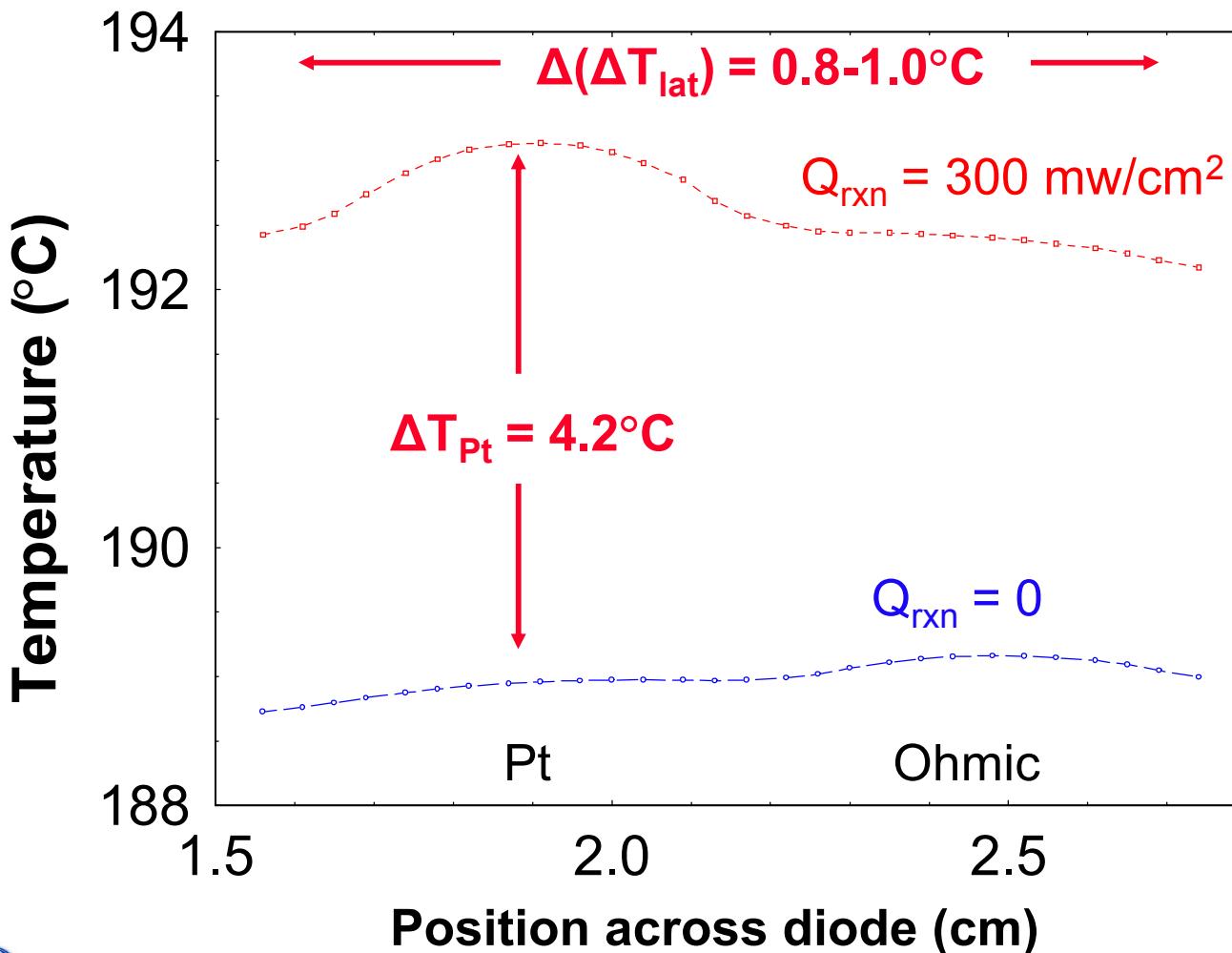
Equivalent thermal circuit



# Full 3D simulation



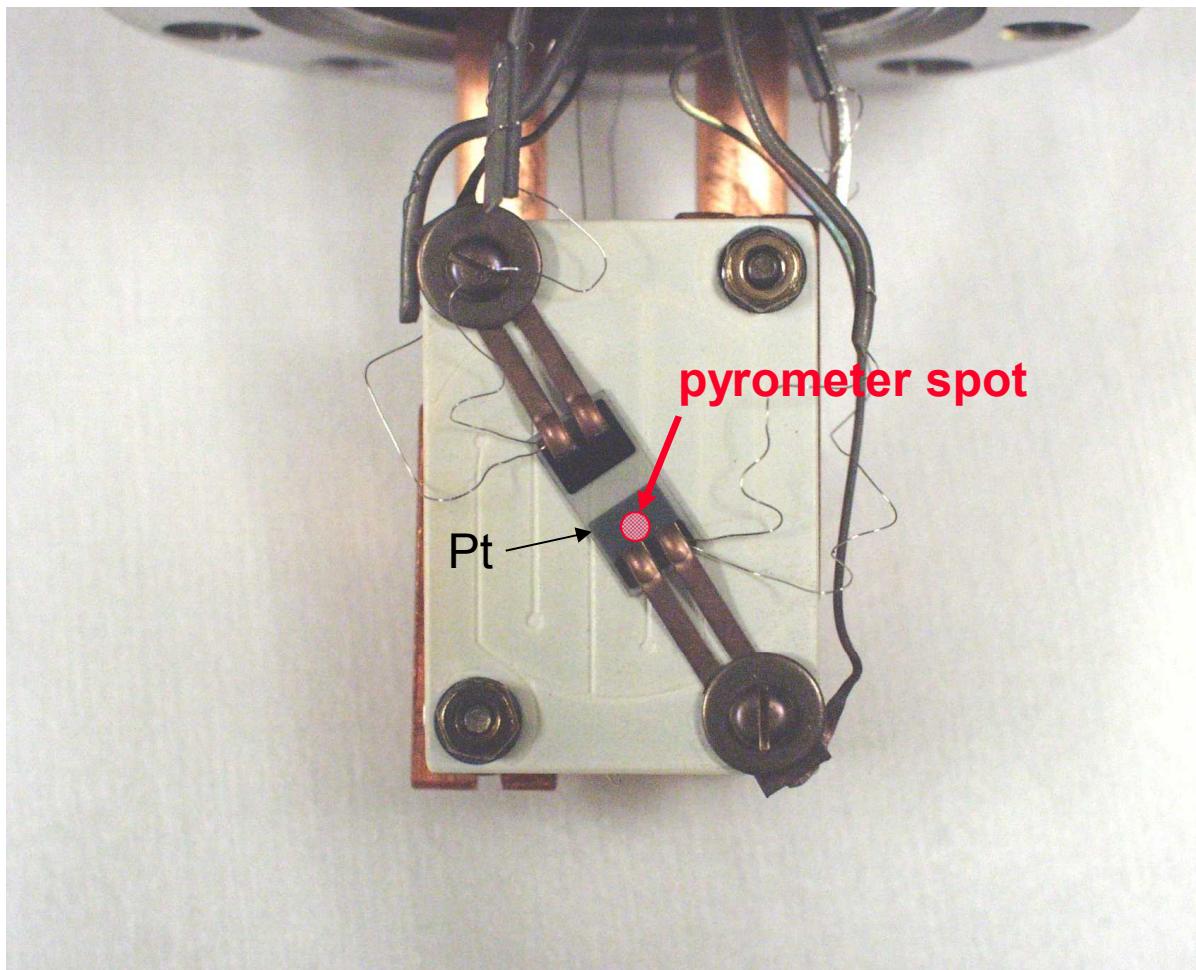
# Full 3D simulation



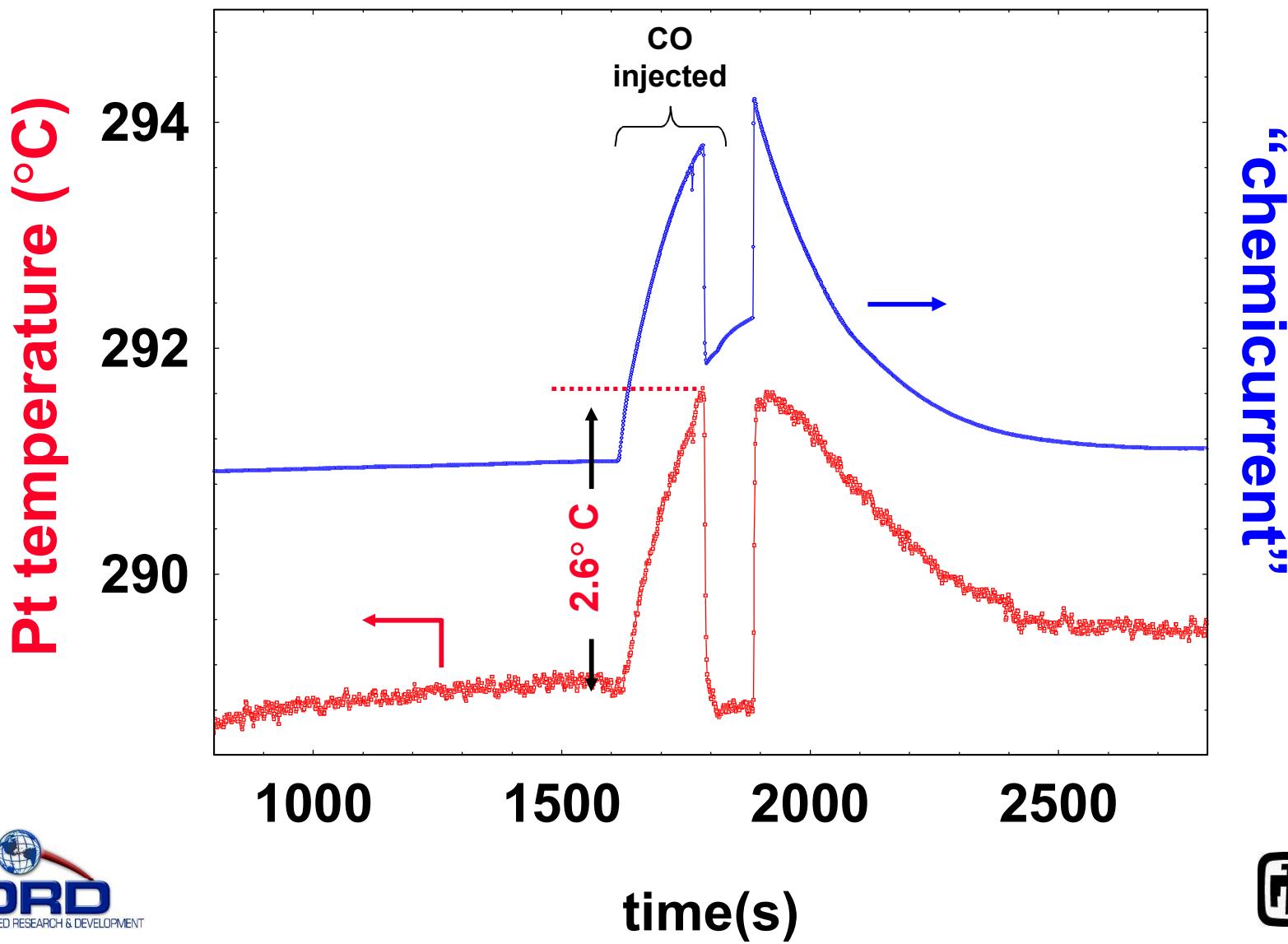


# Experimental methods of temperature measurement

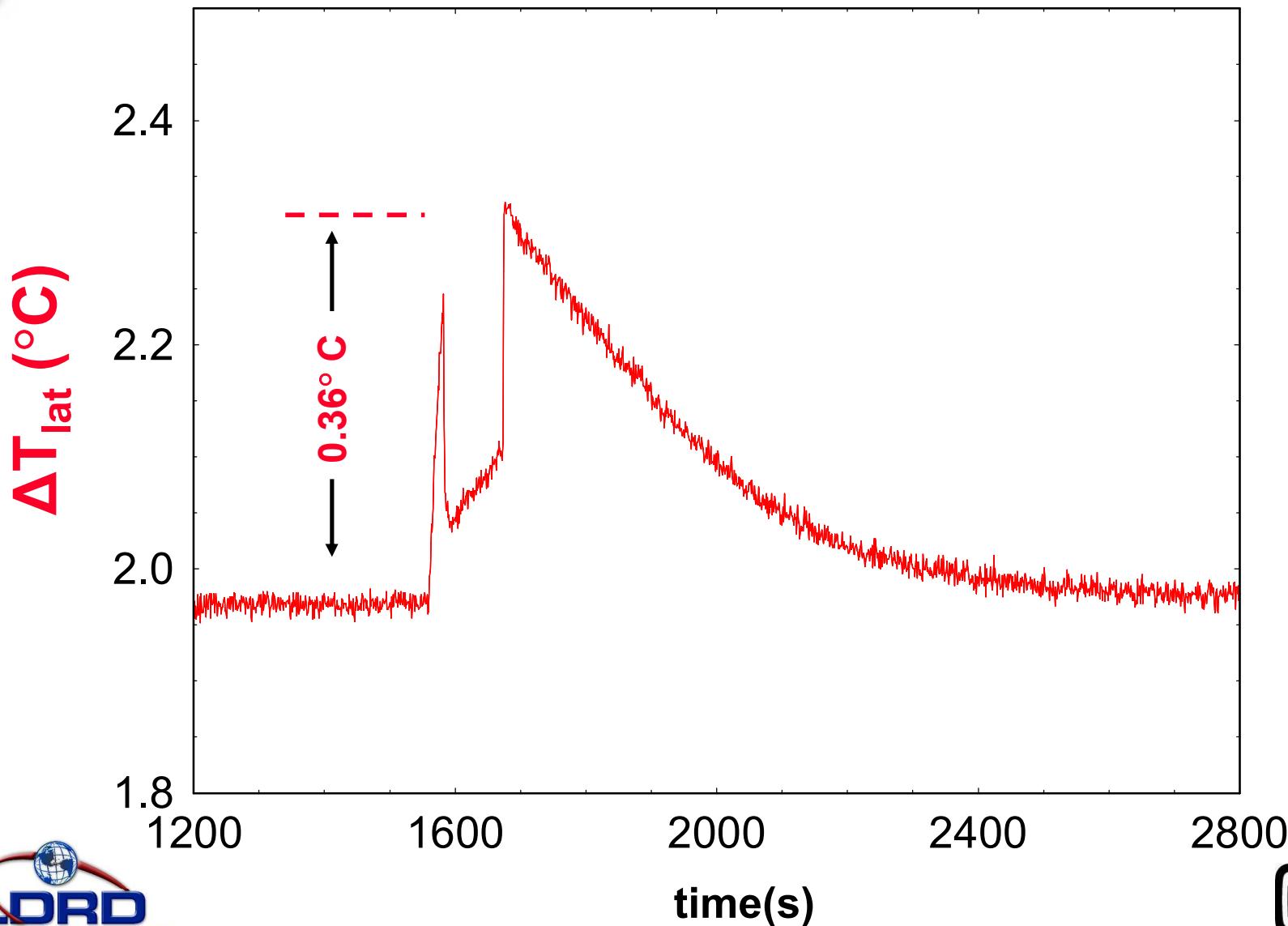
Nanodiode mounted with thermocouples on contacts



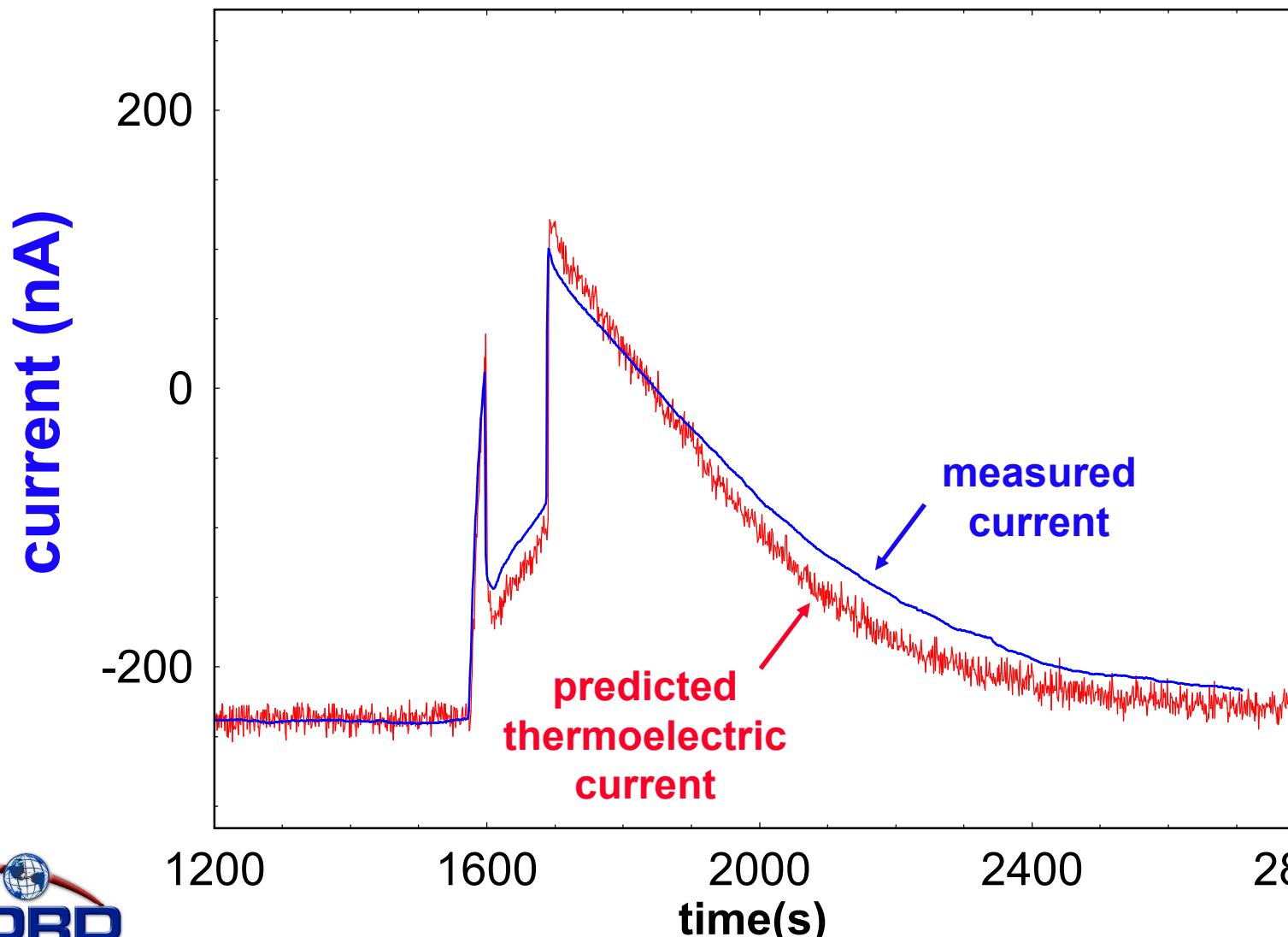
mid-IR (7.5  $\mu\text{m}$ ) pyrometer unambiguously measures  
Pt surface temperature rise during reaction



thermocouples are used to measure the lateral temperature gradient during reaction



Observed current can be quantitatively explained using  $\Delta T_{lat}$ , the Seebeck Coef, and the diode resistance, it is entirely due to thermoelectric voltage





Our calculations and measurements conclusively demonstrate surface temperature rises of a **1-5 °C**, and lateral temperature gradients of **0.2-1.0 °C**

In contrast, Park et al. (Top Cat 2007) concluded that the temperature increase during reaction was negligible (**< 10<sup>-3</sup> °C**), and therefore **dismissed the thermoelectric effect**

They are confusing vertical temperature gradients within the thin Pt and TiO<sub>2</sub> layers ( $\Delta T_{\perp}$ ) with surface temperature changes, and lateral temperature gradients

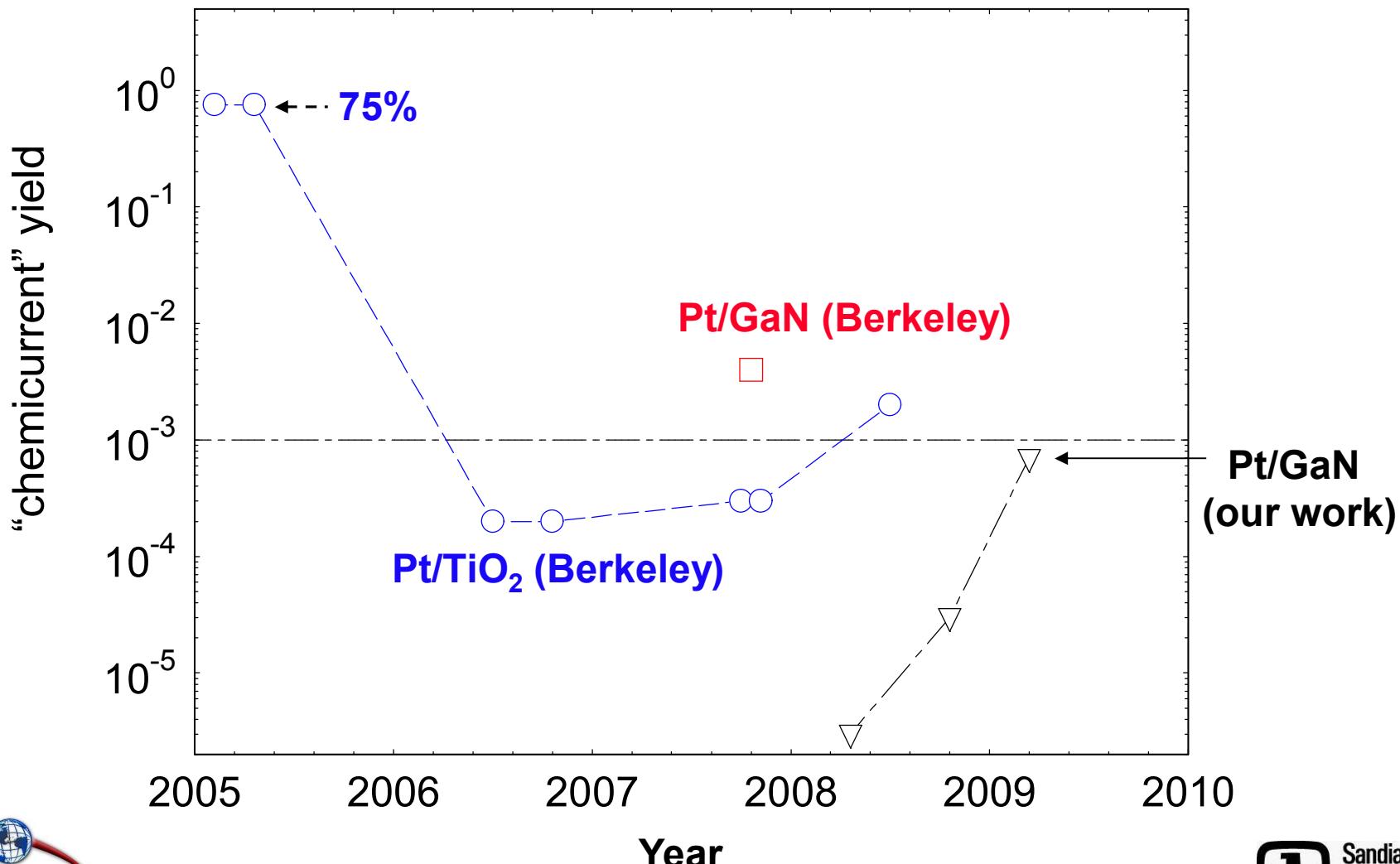


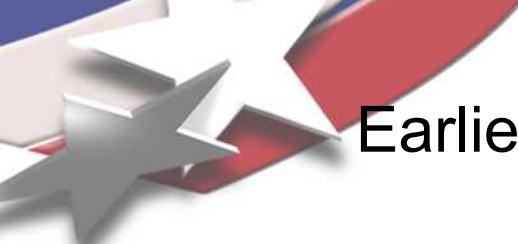
# Summary

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- We have fabricated Pt/GaN and Pt/TiO<sub>2</sub> nanodiodes that exhibit **unmistakable kinetic signatures** of the CO + O<sub>2</sub> reaction, the electronic signal is derived from the **chemical reaction**
- However, the signal dependence on diode shunt resistance indicates that it is **derived from a voltage source**
- With appropriate temperature calculations & measurements, all attributes of the chemical signal can be qualitatively and quantitatively explained by reaction exothermicity and the **thermoelectric properties** of the diode
- measured current is thermoelectric in origin **it is not true chemicurrent**

Our yield measurements are in reasonable agreement with more recent Somorjai results (post 2005)





## Earlier work regarding ballistic (hot) electrons and surface chemical reactions

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1999-2007: Several papers by Nienhaus (U. Duisburg-Essen) and McFarland (UCSB) reported *transient* hot electron formation (**chemicurrents**) by reactions of a variety of chemical species on an assortment of Schottky diodes.

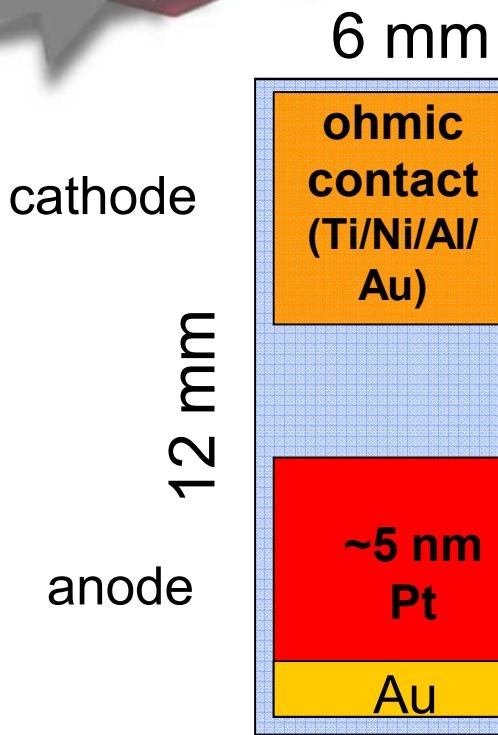
<b>Gases</b> O <sub>2</sub> , NO, NO <sub>2</sub> , H <sub>2</sub> O C <sub>2</sub> H <sub>4</sub> , C <sub>2</sub> H <sub>6</sub> , C <sub>6</sub> H <sub>6</sub> , CO <sub>2</sub> , Xe, H, O,	<b>Diodes</b> Au/Ge, Pd/SiO <sub>2</sub> , Cu/Si, Ag/Si, Fe/Si
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- Generation efficiency correlated with binding energy, but always  $\leq 1\%$

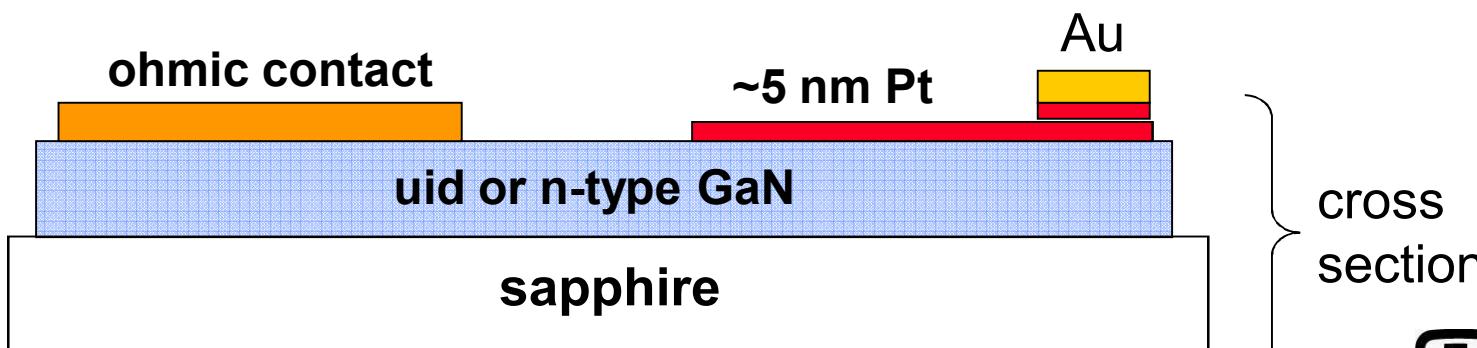
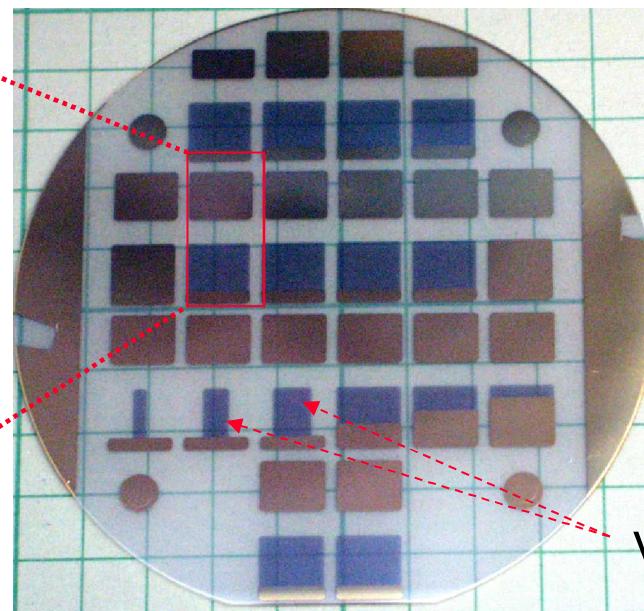
2005: Four papers by Somorjai (Berkeley) on “Catalytic nanodiodes”, used the *steady-state* CO oxidation reaction to achieve up to  $\sim 75\%$  quantum yield (electrons/CO<sub>2</sub>)

We became interested for possible micropower applications; results could be extrapolated to **power conversion efficiencies of 20-30%**

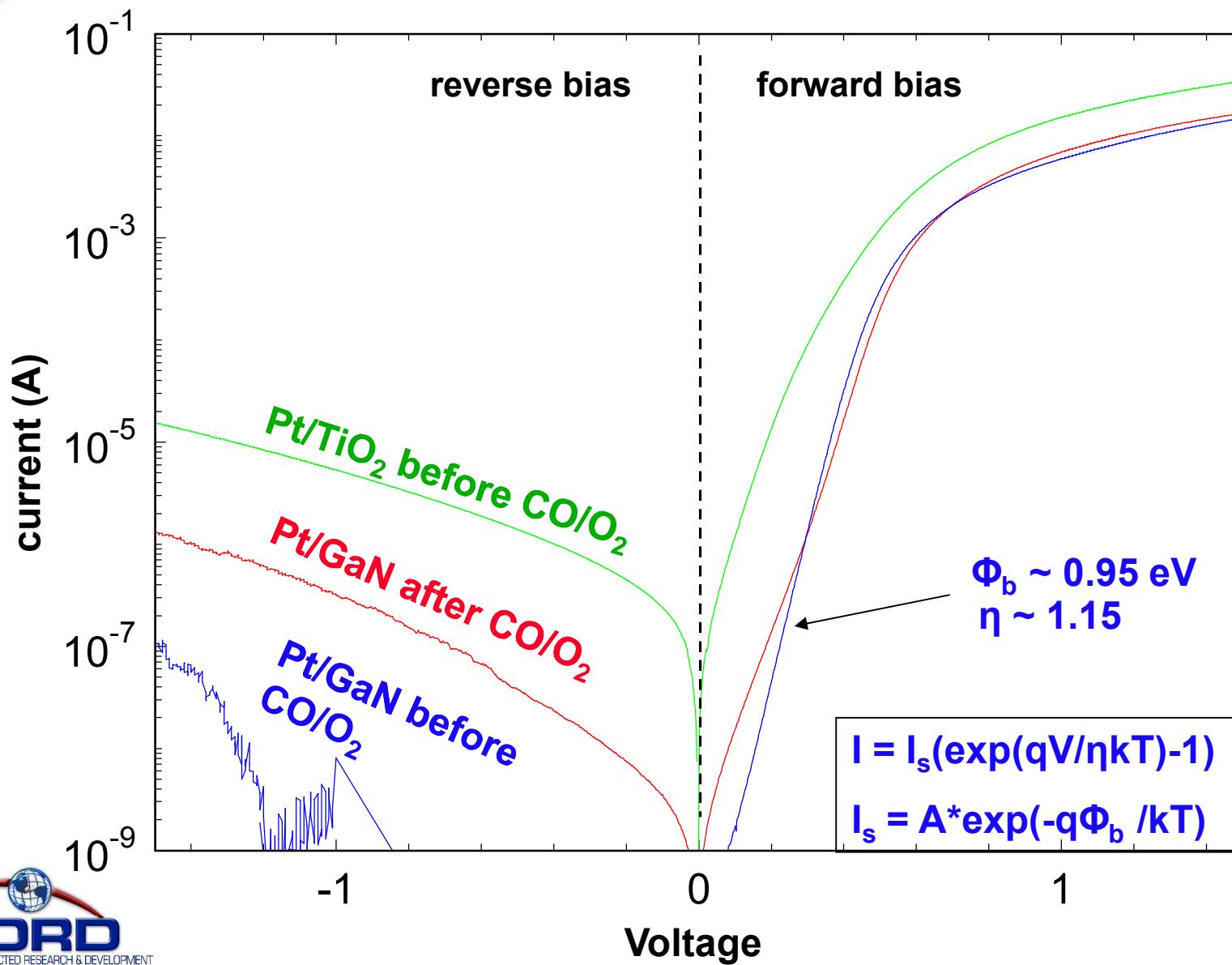
# Schottky diode structure



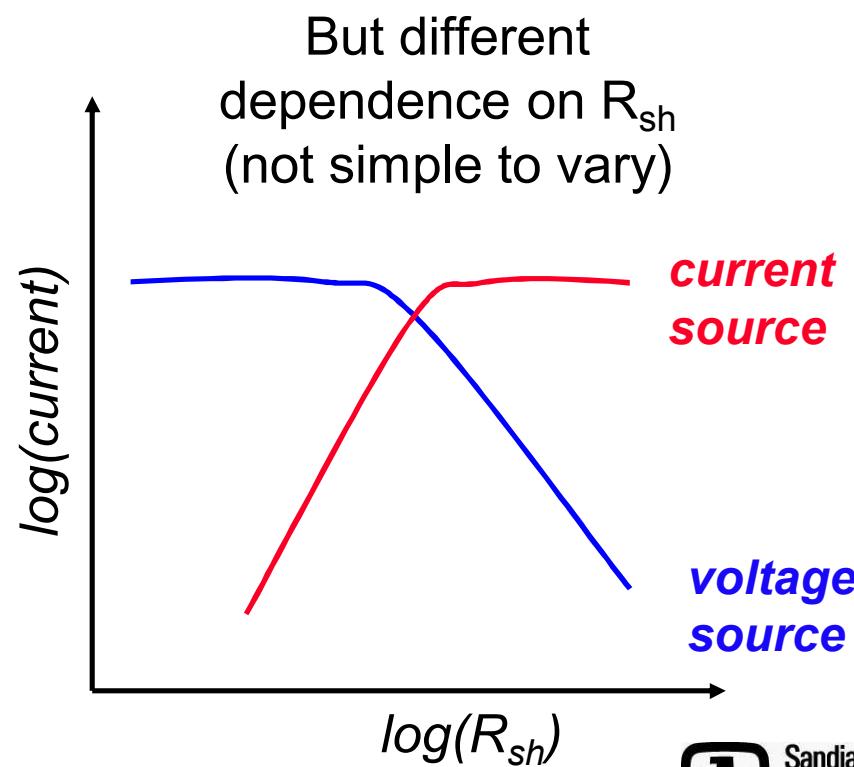
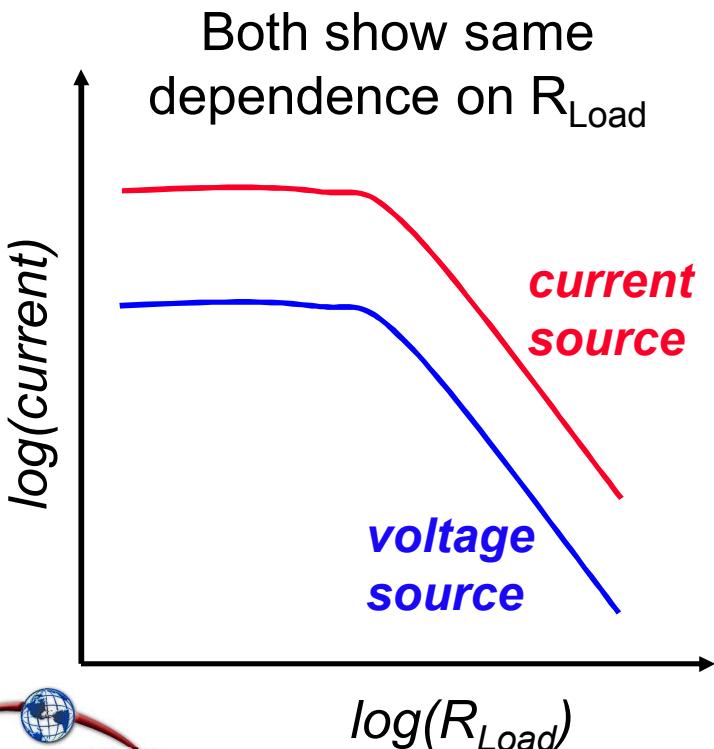
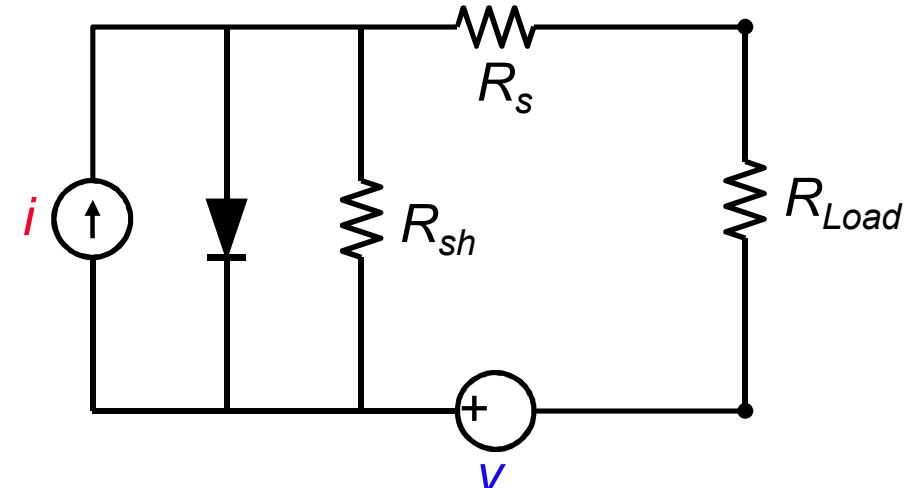
2" wafer before dicing

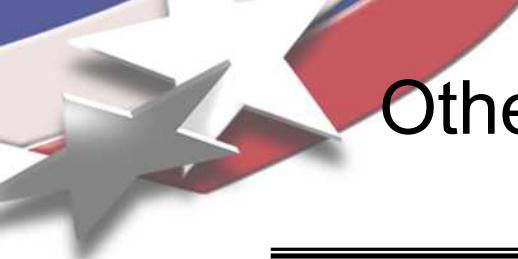


# I-V curves for Pt/GaN(uid) and Pt/TiO<sub>2</sub> diodes



How can you differentiate a current source from a voltage source when shunt ( $R_{sh}$ ) and series ( $R_s$ ) resistance are present?





# Other indications we have simply made a sensitive thermal detector

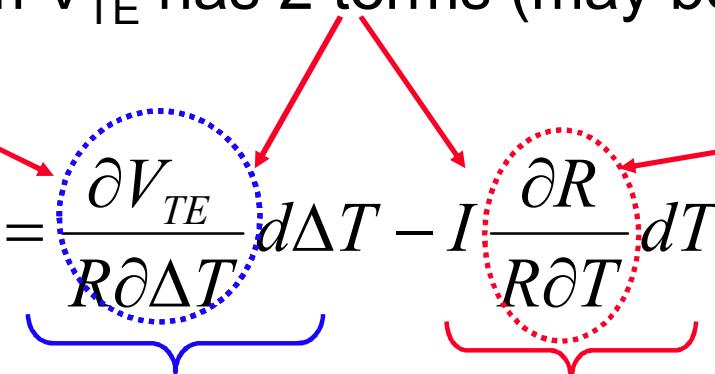
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- Response depends on Schottky diode temperature ( $T$ ) and the lateral temperature difference ( $\Delta T_{lat}$ )

Signal from  $V_{TE}$  has 2 terms (may be of opposite sign)

Seebeck coef

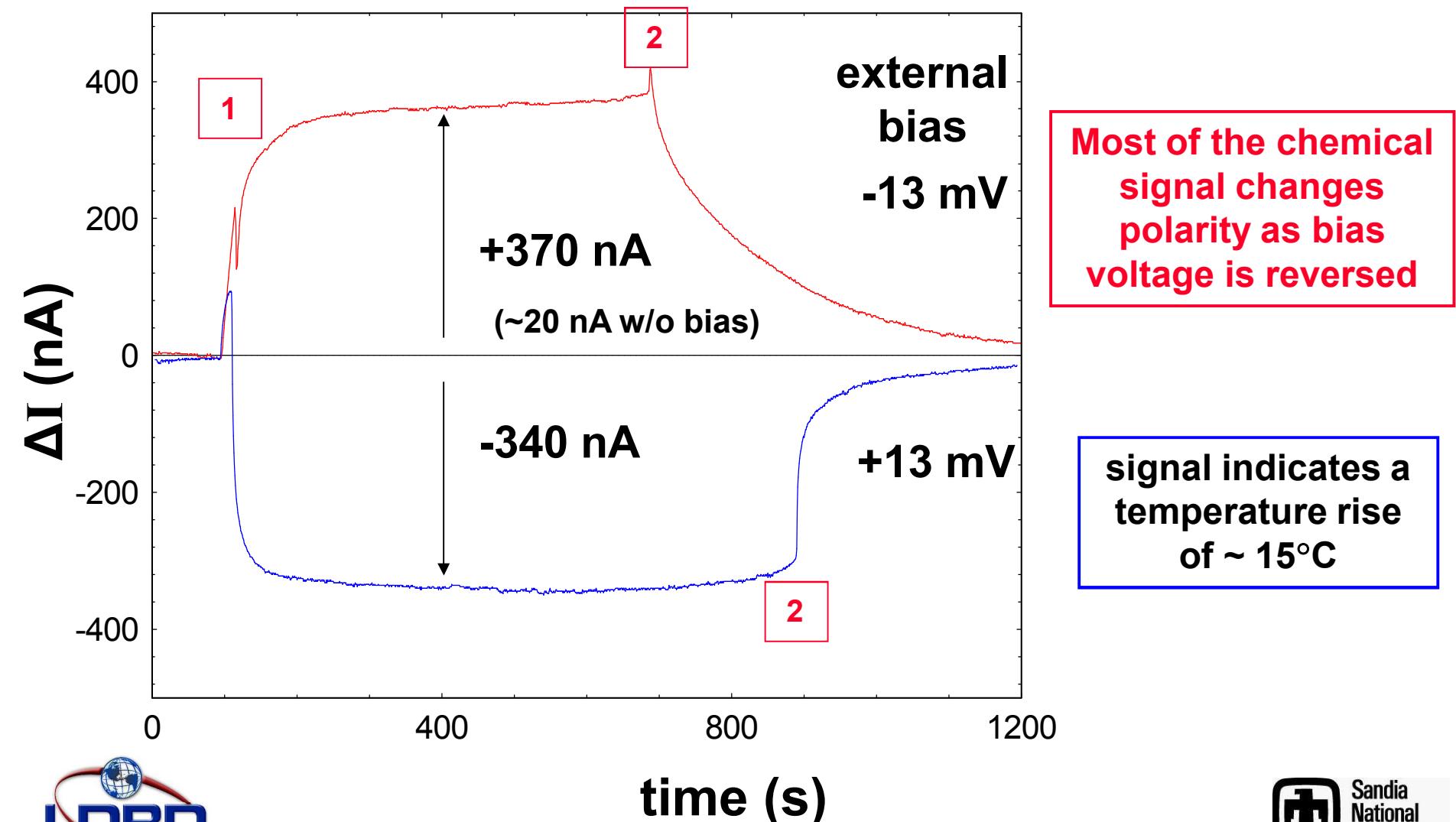
$$dI(\Delta T, T) = \frac{\partial V_{TE}}{R \partial \Delta T} d\Delta T - I \frac{\partial R}{R \partial T} dT$$


The equation is split into two terms. The first term,  $\frac{\partial V_{TE}}{R \partial \Delta T} d\Delta T$ , is circled with a blue dotted line and labeled 'Seebeck coef'. The second term,  $- I \frac{\partial R}{R \partial T} dT$ , is circled with a red dotted line and labeled 'temperature dependence of diode impedance'.

this term is responsible for most of the chemical signal under normal conditions

we can amplify this term with external bias voltage

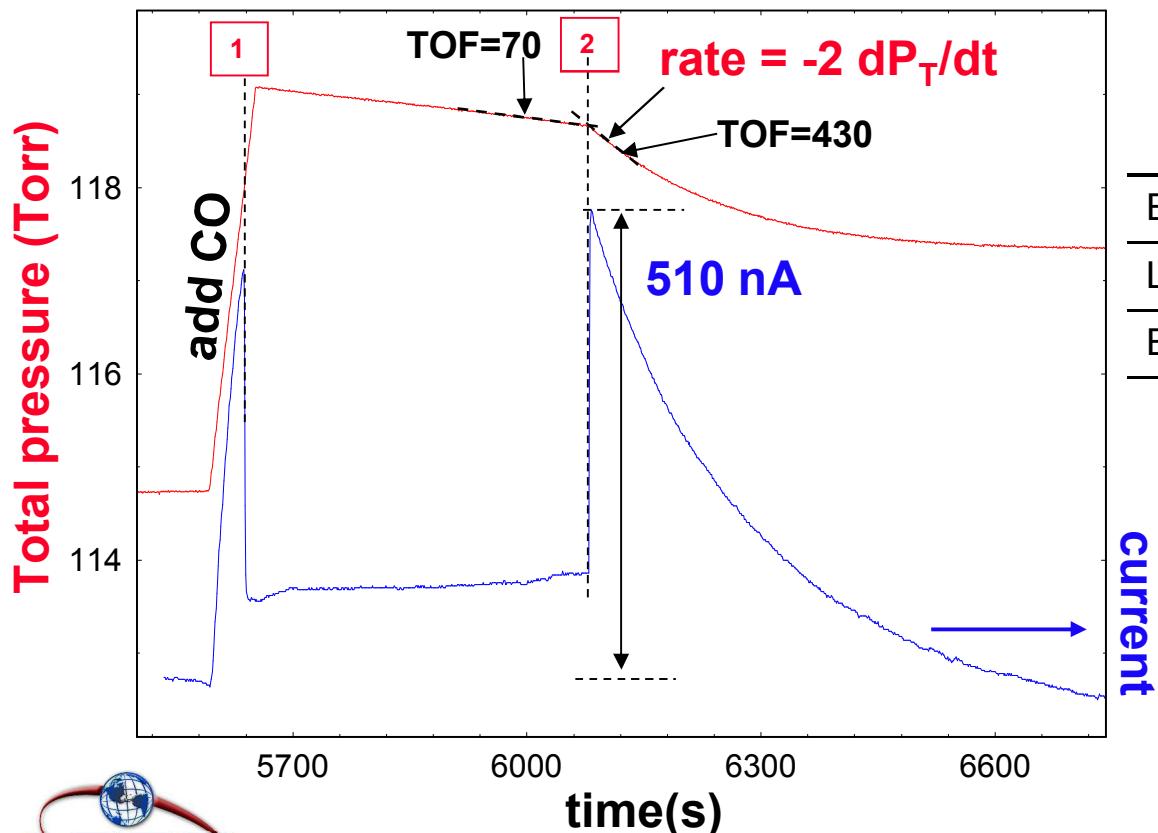
# Thermal signal amplification by small external bias voltage



In order to measure the electron generation yield of the process we also measure the production rate of  $\text{CO}_2$

Use a pressure drop method to measure reaction rates;  
 $\text{CO} + \frac{1}{2} \text{O}_2 \rightarrow \text{CO}_2$  (net loss of  $\frac{1}{2}$  mole)

5 nm Pt/GaN nanodiode, 270°C



Sandia results	Highest $I_{sc}$	Yield Electrons/ $\text{CO}_2$
Early 2006	200 nA	1-3e-6
Late 2008	700 nA	3e-5
Early 2009	2000 nA	7e-4

“Improvements” are due to increasing GaN doping levels



## Review of Somorjai's results

**2005** At least 4 papers and several popular press articles; Initial results for Pt/TiO<sub>2</sub>,  $\epsilon$  as high as 0.75!, currents as high as 40  $\mu$ A (area  $\sim$ 1 mm<sup>2</sup>) at only 80°C. Reported strong dependence on metal thickness. Pt/GaN devices were less efficient, but had currents of >200 nA/mm<sup>2</sup> at 150 °C

**2006** 3 papers, some repetition but results are generally less impressive than 2005 papers in terms of currents and temperatures. Some discussion of “thermoelectric” current. Efficiency not discussed

**2007** October JPhysChem.  $\epsilon$  = 2e-4 to 4e-3, now GaN better than TiO<sub>2</sub>. Temp range higher than earlier work, currents mostly in 50-500 nA. More discussion of “thermoelectric current

**2008** July, Nanolett.  $\epsilon$  = .001-.003, Pt/Au/TiO<sub>2</sub>. Currents 50-150 nA. Some discussion of Seebeck coef.

**2008** Aug, ACS Meeting, when asked (by Creighton) why they could not reproduce the 75% result (2005), Somorjai replied that it was a device “fabrication” problem.